

Title (en)  
ARRANGEMENT AND METHOD FOR MEASURING A TEMPERATURE

Title (de)  
ANORDNUNG UND VERFAHREN ZUM MESSEN EINER TEMPERATUR

Title (fr)  
PROCEDE ET SYSTEME POUR MESURER UNE TEMPERATURE

Publication  
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Application  
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Abstract (en)  
[origin: WO9835440A1] The invention relates to an arrangement and method for measuring the temperature of a component, in particular of a contactless switch, whereby a transistor or diode is used as a temperature sensor.

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**H03K 17/08**

IPC 8 full level  
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